	Application No.	Applicant(s)
Notice of Allowability	10/619,883	FUKUSHO ET AL.
	Examiner	Art Unit
	Chaine S. Vados III	2622
	Chriss S. Yoder, III	2622
The MAILING DATE of this communication appears on the cover sheet with the correspondence address All claims being allowable, PROSECUTION ON THE MERITS IS (OR REMAINS) CLOSED in this application. If not included herewith (or previously mailed), a Notice of Allowance (PTOL-85) or other appropriate communication will be mailed in due course. THIS NOTICE OF ALLOWABILITY IS NOT A GRANT OF PATENT RIGHTS. This application is subject to withdrawal from issue at the initiative of the Office or upon petition by the applicant. See 37 CFR 1.313 and MPEP 1308.		
1. This communication is responsive to <u>amendment filed 12/19/2006</u> .		
2. The allowed claim(s) is/are 14-26 (now renumbered 1-14).		
 3.		
2. Certified copies of the priority documents have been received in Application No		
3. Copies of the certified copies of the priority documents have been received in this national stage application from the		
International Bureau (PCT Rule 17.2(a)).		
* Certified copies not received:		
Applicant has THREE MONTHS FROM THE "MAILING DATE" of this communication to file a reply complying with the requirements noted below. Failure to timely comply will result in ABANDONMENT of this application. THIS THREE-MONTH PERIOD IS NOT EXTENDABLE.		
4. A SUBSTITUTE OATH OR DECLARATION must be submitted. Note the attached EXAMINER'S AMENDMENT or NOTICE OF INFORMAL PATENT APPLICATION (PTO-152) which gives reason(s) why the oath or declaration is deficient.		
5. CORRECTED DRAWINGS (as "replacement sheets") must be submitted.		
(a) ☐ including changes required by the Notice of Draftsperson's Patent Drawing Review (PTO-948) attached		
1) hereto or 2) to Paper No./Mail Date		
(b) ☐ including changes required by the attached Examiner's Amendment / Comment or in the Office action of Paper No./Mail Date		
Identifying Indicia such as the application number (see 37 CFR 1.84(c)) should be written on the drawings in the front (not the back) of each sheet. Replacement sheet(s) should be labeled as such in the header according to 37 CFR 1.121(d).		
6. DEPOSIT OF and/or INFORMATION about the deposit of BIOLOGICAL MATERIAL must be submitted. Note the attached Examiner's comment regarding REQUIREMENT FOR THE DEPOSIT OF BIOLOGICAL MATERIAL.		
Attachment(s)	E	teatona Annicostica
 Notice of References Cited (PTO-892) Notice of Draftperson's Patent Drawing Review (PTO-948) 	 5. ☐ Notice of Informal P 6. ☐ Interview Summary 	• •
	Paper No./Mail Da	te
 Information Disclosure Statements (PTO/SB/08), Paper No./Mail Date 	7. Examiner's Amendr	ment/Comment
4. Examiner's Comment Regarding Requirement for Deposit	8. 🛛 Examiner's Stateme	ent of Reasons for Allowance
of Biological Material	9. 🗌 Other	

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DETAILED ACTION

Response to Amendment

The Examiner notes that the amendment to the title filed on December 19, 2006 is accepted.

Allowable Subject Matter

Claims 14-27 are allowed.

The following is an examiner's statement of reasons for allowance:

- 1. As for claim 14, the prior art does not teach or fairly suggest the use of a method of making a solid-state image pickup device that provides a light receiving sensor portion which performs photoelectric conversion in a surface layer portion of a substrate, uses a plasma CVD process to provide an in-layer lens, which converges incident light to said light receiving sensor portion, in a layer above said light receiving sensor portion, uses a plasma CVD process to provide, on said in-layer lens, an antireflection film formed of material having a refractive index which is an intermediate value between the refractive index of said in-layer lens and the refractive index of a color filter that is provided over said antireflection film.
- 2. As for claim 23, the prior art does not teach or fairly suggest the use of a method of making a solid-state image pickup device comprising the steps of providing a light receiving sensor portion which performs photoelectric conversion in a surface layer portion of a substrate, providing an interlayer film on said light receiving sensor portion, and using a plasma CVD process to provide, on said interlayer film, both an in-layer lens and an antireflection film, wherein the in-layer lens converges incident light through

said antireflection film onto said light receiving sensor portion and the antireflection film is formed of material having a refractive index is an intermediate value between the refractive index of said in-layer lens and the refractive index of said interlayer film.

Any comments considered necessary by applicant must be submitted no later than the payment of the issue fee and, to avoid processing delays, should preferably accompany the issue fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for Allowance."

Conclusion

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Chriss S. Yoder, III whose telephone number is (571) 272-7323. The examiner can normally be reached on M-F: 8 - 4:30.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Vivek Srivastava can be reached on (571) 272-7304. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

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Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free). If you would like assistance from a USPTO Customer Service Representative or access to the automated information system, call 800-786-9199 (IN USA OR CANADA) or 571-272-1000.

CSY March 27, 2007

> DAVID OMETZ SUPERVISORY PATENT EXAMINER